



Dual Modulus Prescaler

These devices are two-modulus prescalers which will divide by 5 and 6, 8 and 9, respectively. A MECL-to-MTTL translator is provided to interface directly with the MC12014 Counter Control Logic. In addition, there is a buffered clock input and MECL bias voltage source.

- MC12009 480 MHz ($\div 5/6$), MC12011 550 MHz ($\div 8/9$)
- MECL to MTTL Translator on Chip
- MECL and MTTL Enable Inputs
- 5.0 or -5.2 V Operation*
- Buffered Clock Input — Series Input RC Typ, 20 Ω and 4.0 pF
- V_{BB} Reference Voltage
- 310 mW (Typ)

* When using a 5.0 V supply, apply 5.0 V to Pin 1 (V_{CCO}), Pin 6 (MTTL V_{CC}), Pin 16 (V_{CC}), and ground Pin 8 (V_{EE}). When using -5.2 V supply, ground Pin 1 (V_{CCO}), Pin 6 (MTTL V_{CC}), and Pin 16 (V_{CC}) and apply -5.2 V to Pin 8 (V_{EE}). If the translator is not required, Pin 6 may be left open to conserve dc power drain.

MAXIMUM RATINGS

Characteristic	Symbol	Rating	Unit
(Ratings above which device life may be impaired)			
Power Supply Voltage ($V_{CC} = 0$)	V_{EE}	-8.0	Vdc
Input Voltage ($V_{CC} = 0$)	V_{in}	0 to V_{EE}	Vdc
Output Source Current Continuous	I_O	< 50	mAdc
Surge		< 100	
Storage Temperature Range	T_{stg}	-65 to 175	$^{\circ}\text{C}$

(Recommended Maximum Ratings above which performance may be degraded)

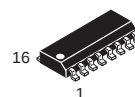
Operating Temperature Range MC12009, MC12011	T_A	-30 to 85	$^{\circ}\text{C}$
DC Fan-Out (Note 1) (Gates and Flip-Flops)	n	70	—

NOTES: 1. AC fan-out is limited by desired system performance.
2. ESD data available upon request.

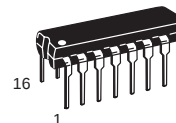
MC12009 MC12011

MECL PLL COMPONENTS DUAL MODULUS PRESCALER

SEMICONDUCTOR TECHNICAL DATA

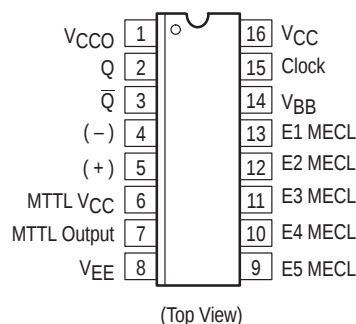


D SUFFIX
PLASTIC PACKAGE
CASE 751B
(SO-16)



P SUFFIX
PLASTIC PACKAGE
CASE 648

PIN CONNECTIONS



ORDERING INFORMATION

Device	Operating Temperature Range	Package
MC12009D	$T_A = -35$ to 85°C	SO-16
MC12011D		Plastic DIP
MC12009P		
MC12011P		

MC12009 MC12011

Figure 1. Logic Diagrams

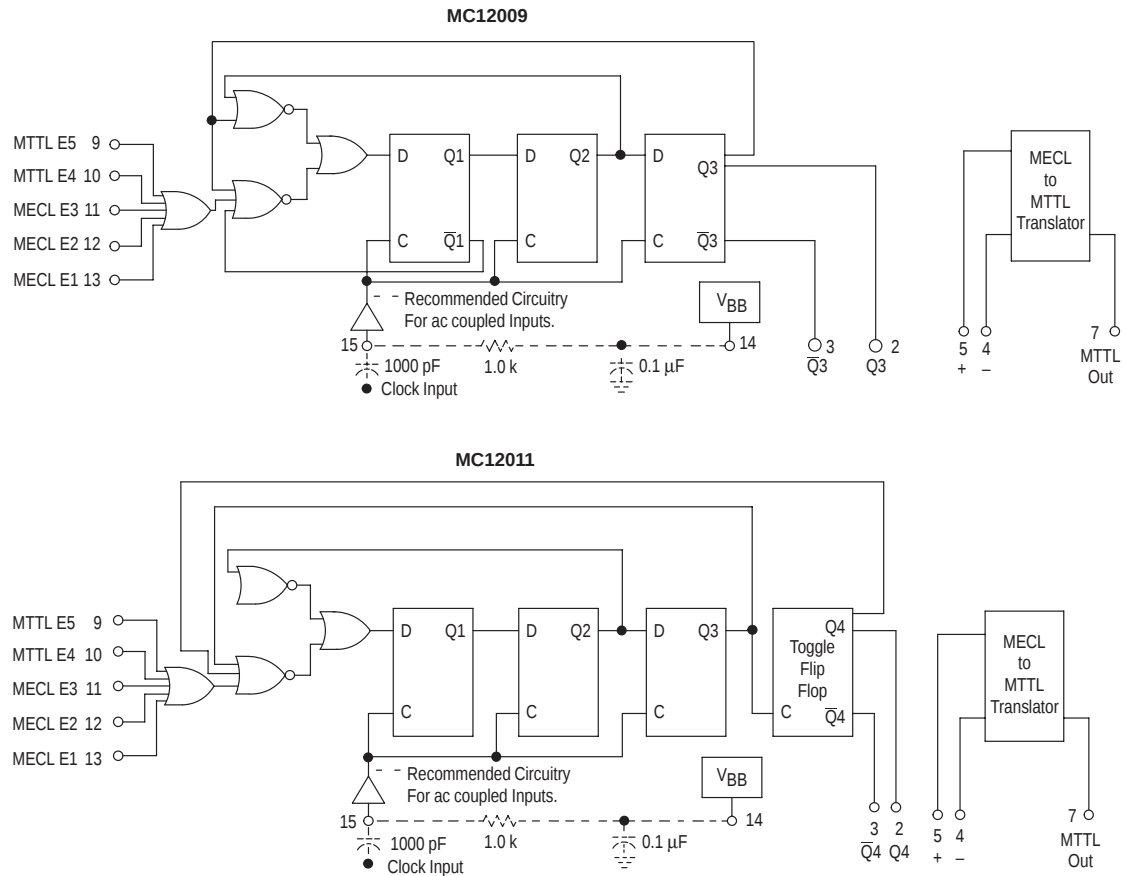
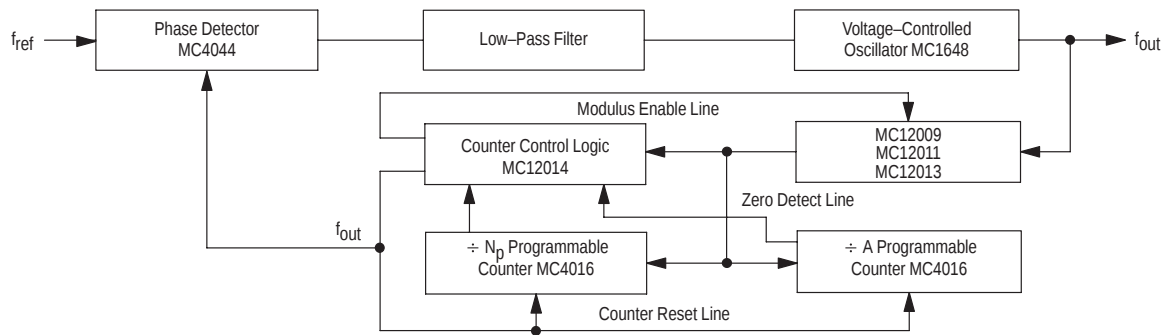


Figure 2. Typical Frequency Synthesizer Application

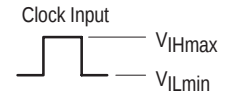


MC12009 MC12011

ELECTRICAL CHARACTERISTICS (Supply Voltage = -5.2 V, unless otherwise noted.)

Characteristic	Symbol	Pin Under Test	Test Limits						Unit
			−30°C		25°C		85°C		
			Min	Max	Min	Max	Min	Max	
Power Supply Drain Current	I _{CC1}	8	−88		−80		−80		mAdc
	I _{CC2}	6		5.2		5.2		5.2	mAdc
Input Current	I _{inH1}	15		375		250		250	μAdc
		11		375		250		250	
		12		375		250		250	
		13		375		250		250	
	I _{inH2}	4	1.7	6.0	2.0	6.0	2.0	6.4	mAdc
		5	1.7	6.0	2.0	6.0	2.0	6.4	
	I _{inH3}	5	0.7	3.0	1.0	3.0	1.0	3.6	
	I _{inH4}	9		100		100		100	μAdc
10		100		100		100			
Leakage Current	I _{inL1}	15	−10		−10		−10		μAdc
		11	−10		−10		−10		
		12	−10		−10		−10		
		13	−10		−10		−10		
	I _{inL2}	9	−1.6		−1.6		−1.6		mAdc
		10	−1.6		−1.6		−1.6		
Reference Voltage	V _{BB}	14			−1.360	−1.160			Vdc
Logic '1' Output Voltage	V _{OH1} (Note 1)	2	−1.100	−0.890	−1.000	−0.810	−0.930	−0.700	Vdc
		3	−1.100	−0.890	−1.000	−0.810	−0.930	−0.700	
	V _{OH2}	7	−2.8		−2.6		−2.4		
Logic '0' Output Voltage	V _{OL1} (Note 1)	2	−1.990	−1.675	−1.950	−1.650	−1.925	−1.615	Vdc
		3	−1.990	−1.675	−1.950	−1.650	−1.925	−1.615	
	V _{OL2}	7		−4.26		−4.40		−4.48	
Logic '1' Threshold Voltage	V _{OHA} (Note 2)	2	−1.120		−1.020		−0.950		Vdc
3	−1.120		−1.020		−0.950				
Logic '0' Threshold Voltage	V _{OLA} (Note 3)	2		−1.655		−1.630		−1.595	Vdc
3		−1.655		−1.630		−1.595			
Short Circuit Current	I _{OS}	7	−65	−20	−65	−20	−65	−20	mAdc

- NOTES:** 1. Test outputs of the device must be tested by sequencing through the truth table. All input, power supply and ground voltages must be maintained between tests. The clock input is the waveform shown.
 2. In addition to meeting the output levels specified, the device must divide by 5 or 8 during this test. The clock input is the waveform shown.
 3. In addition to meeting the output levels specified, the device must divide by 6 or 9 during this test. The clock input is the waveform shown.



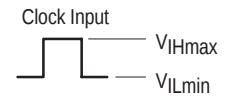
Each MECL 10,000 series circuit has been designed to meet the dc specifications shown in the test table, after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse air flow greater than 500 linear fpm is maintained. Outputs are terminated through a 50 Ω resistor to -2.0 V. Test procedures are shown for only one gate. The other gates are tested in the same manner.

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ELECTRICAL CHARACTERISTICS (continued) (Supply Voltage = –5.2 V, unless otherwise noted.)

@ Test Temperature –30°C 25°C 85°C			TEST VOLTAGE/CURRENT VALUES						Gnd
			Volts						
			V _{IH} max	V _{IL} min	V _{IH} Amin	V _{IL} Amax	V _{IH}	V _{IL} H	
			–0.890	–1.990	–1.205	–1.500	–2.8	–4.7	
			–0.810	–1.950	–1.105	–1.475	–2.8	–4.7	
			–0.700	–1.925	–1.035	–1.440	–2.8	–4.7	
Characteristic	Symbol	Pin Under Test	TEST VOLTAGE APPLIED TO PINS LISTED BELOW						Gnd
			V _{IH} max	V _{IL} min	V _{IH} Amin	V _{IL} Amax	V _{IH}	V _{IL}	
Power Supply Drain Current	I _{CC1}	8							1,16
	I _{CC2}	6	4	5					6
Input Current	I _{inH1}	15	15						1,16
		11	11						1,16
		12	12						1,16
		13	13						1,16
	I _{inH2}	4	5	4					6
		5	5	4					6
I _{inH3}	5	4	5					6	
I _{inH4}	9					9		1,16	
		10				10		1,16	
Leakage Current	I _{inL1}	15							1,16
		11							1,16
		12							1,16
		13							1,16
I _{inL2}	9						9	1,16	
		10					10	1,16	
Reference Voltage	V _{BB}	14							1,16
Logic '1' Output Voltage	V _{OH1} (Note 1)	2		11,12,13				9,10	1,16
		3		11,12,13				9,10	1,16
	V _{OH2}	7	5	4					6
Logic '0' Output Voltage	V _{OL1} (Note 1)	2		11,12,13				9,10	1,16
		3		11,12,13				9,10	1,16
	V _{OL2}	7	4	5					6
Logic '1' Threshold Voltage	V _{OHA} (Note 2)	2			11,12,13				1,16
		3			11,12,13				1,16
Logic '0' Threshold Voltage	V _{OLA} (Note 3)	2				11,12,13			1,16
		3				11,12,13			1,16
Short Circuit Current	I _{OS}	7	5	4				7	6

- NOTES:** 1. Test outputs of the device must be tested by sequencing through the truth table. All input, power supply and ground voltages must be maintained between tests. The clock input is the waveform shown.
 2. In addition to meeting the output levels specified, the device must divide by 5 or 8 during this test. The clock input is the waveform shown.
 3. In addition to meeting the output levels specified, the device must divide by 6 or 9 during this test. The clock input is the waveform shown.

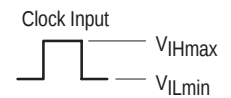


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ELECTRICAL CHARACTERISTICS (continued) (Supply Voltage = -5.2 V, unless otherwise noted.)

@ Test Temperature			TEST VOLTAGE/CURRENT VALUES						
			Volts			mA			
			V _{IHT}	V _{ILT}	V _{EE}	I _L	I _{OL}	I _{OH}	
			−3.2	−4.4	−5.2	−0.25	16	−0.40	
			−3.2	−4.4	−5.2	−0.25	16	−0.40	
		85°C	−3.2	−4.4	−5.2	−0.25	16	−0.40	
Characteristic	Symbol	Pin Under Test	TEST VOLTAGE APPLIED TO PINS LISTED BELOW						Gnd
			V _{IHT}	V _{ILT}	V _{EE}	I _L	I _{OL}	I _{OH}	
Power Supply Drain Current	I _{CC1}	8			8				1,16
	I _{CC2}	6			8				6
Input Current	I _{inH1}	15			8				1,16
		11	9,10		8				1,16
		12	9,10		8				1,16
		13	9,10		8				1,16
	I _{inH2}	4			8				6
		5			8				6
	I _{inH3}	5			8				6
	I _{inH4}	9			8				1,16
		10			8				1,16
Leakage Current	I _{inL1}	15			8,15				1,16
		11			8,11				1,16
		12			8,12				1,16
		13			8,13				1,16
	I _{inL2}	9			8				1,16
		10			8				1,16
Reference Voltage	V _{BB}	14			8	14			1,16
Logic '1' Output Voltage	V _{OH1} (Note 1)	2			8				1,16
		3			8				1,16
	V _{OH2}	7			8			7	6
Logic '0' Output Voltage	V _{OL1} (Note 1)	2			8				1,16
		3			8				1,16
	V _{OL2}	7			8		7		6
Logic '1' Threshold Voltage	V _{OHA} (Note 2)	2	9,10		8				1,16
		3	9,10		8				1,16
Logic '0' Threshold Voltage	V _{OLA} (Note 2)	2		9,10	8				1,16
		3		9,10	8				1,16
Short Circuit Current	I _{OS}	7			8				6

- NOTES:** 1. Test outputs of the device must be tested by sequencing through the truth table. All input, power supply and ground voltages must be maintained between tests. The clock input is the waveform shown.
 2. In addition to meeting the output levels specified, the device must divide by 5 or 8 during this test. The clock input is the waveform shown.
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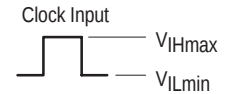


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ELECTRICAL CHARACTERISTICS (Supply Voltage = 5.0 V, unless otherwise noted.)

Characteristic	Symbol	Pin Under Test	Test Limits						Unit
			−30°C		25°C		85°C		
			Min	Max	Min	Max	Min	Max	
Power Supply Drain Current	I _{CC1}	8	−88		−80		−80		mAdc
	I _{CC2}	6		5.2		5.2		5.2	mAdc
Input Current	I _{inH1}	15		375		250		250	μAdc
		11		375		250		250	
		12		375		250		250	
		13		375		250		250	
	I _{inH2}	4	1.7	6.0	2.0	6.0	2.0	6.4	mAdc
		5	1.7	6.0	2.0	6.0	2.0	6.4	
	I _{inH3}	5	0.7	3.0	1.0	3.0	1.0	3.6	
	I _{inH4}	9			100	100		100	μAdc
10			100	100		100			
Leakage Current	I _{inL1}	15	−10		−10		−10		μAdc
		11	−10		−10		−10		
		12	−10		−10		−10		
		13	−10		−10		−10		
	I _{inL2}	9	−1.6		−1.6		−1.6		mAdc
		10	−1.6		−1.6		−1.6		
Reference Voltage	V _{BB}	14			3.67	3.87			Vdc
Logic '1' Output Voltage	V _{OH1} (Note 1)	2	3.900	4.110	4.000	4.190	4.070	4.300	Vdc
		3	3.900	4.110	4.000	4.190	4.070	4.300	
	V _{OH2}	7	2.4		2.6		2.8		
Logic '0' Output Voltage	V _{OL1} (Note 1)	2	3.070	3.385	3.110	3.410	3.135	3.445	Vdc
		3	3.070	3.385	3.110	3.410	3.135	3.445	
	V _{OL2}	7		0.94		0.80		0.72	
Logic '1' Threshold Voltage	V _{OHA} (Note 2)	2	3.880		3.980		4.050		Vdc
3	3.880		3.980		4.050				
Logic '0' Threshold Voltage	V _{OLA} (Note 3)	2		3.405		3.430		3.465	Vdc
3		3.405		3.430		3.465			
Short Circuit Current	I _{OS}	7	−65	−20	−65	−20	−65	−20	mAdc

- NOTES:** 1. Test outputs of the device must be tested by sequencing through the truth table. All input, power supply and ground voltages must be maintained between tests. The clock input is the waveform shown.
2. In addition to meeting the output levels specified, the device must divide by 5 or 8 during this test. The clock input is the waveform shown.
3. In addition to meeting the output levels specified, the device must divide by 6 or 9 during this test. The clock input is the waveform shown.



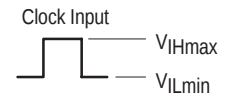
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ELECTRICAL CHARACTERISTICS (continued) (Supply Voltage = 5.0 V, unless otherwise noted.)

@ Test Temperature			TEST VOLTAGE/CURRENT VALUES						(V _{EE}) Gnd	
			Volts							
			V _{IH} max	V _{IL} min	V _{IH} Amin	V _{IL} Amax	V _{IH}	V _{IL} H		
			−30°C	4.110	3.070	3.795	3.500	2.4		0.5
			25°C	4.190	3.110	3.895	3.525	2.4		0.5
			85°C	4.300	3.135	3.965	3.560	2.4		0.5
Characteristic	Symbol	Pin Under Test	TEST VOLTAGE APPLIED TO PINS LISTED BELOW							
			V _{IH} max	V _{IL} min	V _{IH} Amin	V _{IL} Amax	V _{IH}	V _{IL}		
Power Supply Drain Current	I _{CC} 1	8							8	
	I _{CC} 2	6	4	5					8	
Input Current	I _{in} H1	15	15						8	
		11	11						8	
		12	12						8	
		13	13						8	
	I _{in} H2	4	5	4					8	
		5	5	4					8	
I _{in} H3	5	4	5					8		
I _{in} H4	9					9		8		
	10					10		8		
Leakage Current	I _{in} L1	15							8,15	
		11							8,11	
12								8,12		
13								8,13		
I _{in} L2	9						9	8		
	10						10	8		
Reference Voltage	V _{BB}	14							8	
Logic '1' Output Voltage	V _{OH} 1 (Note 1)	2		11,12,13				9,10	8	
		3		11,12,13				9,10	8	
V _{OH} 2	7	5	4						8	
Logic '0' Output Voltage	V _{OL} 1 (Note 1)	2		11,12,13				9,10	8	
		3		11,12,13				9,10	8	
V _{OL} 2	7	4	5						8	
Logic '1' Threshold Voltage	V _{OHA} (Note 2)	2			11,12,13				8	
		3			11,12,13				8	
Logic '0' Threshold Voltage	V _{OLA} (Note 3)	2				11,12,13			8	
		3				11,12,13			8	
Short Circuit Current	I _{OS}	7	5	4				7	8	

- NOTES:** 1. Test outputs of the device must be tested by sequencing through the truth table. All input, power supply and ground voltages must be maintained between tests. The clock input is the waveform shown.
 2. In addition to meeting the output levels specified, the device must divide by 5 or 8 during this test. The clock input is the waveform shown.
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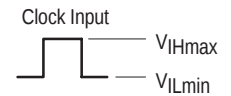


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ELECTRICAL CHARACTERISTICS (continued) (Supply Voltage = 5.0 V, unless otherwise noted.)

@ Test Temperature			TEST VOLTAGE/CURRENT VALUES						(V _{EE}) Gnd	
			Volts			mA				
			V _{IHT}	V _{ILT}	V _{CC}	I _L	I _{OL}	I _{OH}		
			–30°C	2.0	0.8	5.0	–0.25	16		–0.40
			25°C	2.0	0.8	5.0	–0.25	16		–0.40
			85°C	2.0	0.8	5.0	–0.25	16		–0.40
Characteristic	Symbol	Pin Under Test	TEST VOLTAGE APPLIED TO PINS LISTED BELOW							
			V _{IHT}	V _{ILT}	V _{CC}	I _L	I _{OL}	I _{OH}		
Power Supply Drain Current	I _{CC1}	8			1,16				8	
	I _{CC2}	6			6				8	
Input Current	I _{inH1}	15			1,16				8	
		11	9,10		1,16				8	
		12	9,10		1,16				8	
		13	9,10		1,16				8	
	I _{inH2}	4			6				8	
		5			6				8	
	I _{inH3}	5			6				8	
	I _{inH4}	9			1,16				8	
		10			1,16				8	
Leakage Current	I _{inL1}	15			1,16				8,15	
		11			1,16				8,11	
		12			1,16				8,12	
		13			1,16				8,13	
	I _{inL2}	9			1,16				8	
		10			1,16				8	
Reference Voltage	V _{BB}	14			1,16	14			8	
Logic '1' Output Voltage	V _{OH1} (Note 1)	2			1,16				8	
		3			1,16				8	
	V _{OH2}	7			6			7	8	
Logic '0' Output Voltage	V _{OL1} (Note 1)	2			1,16				8	
		3			1,16				8	
	V _{OL2}	7			6		7		8	
Logic '1' Threshold Voltage	V _{OHA} (Note 2)	2	9,10		1,16				8	
		3	9,10		1,16				8	
Logic '0' Threshold Voltage	V _{OLA} (Note 3)	2		9,10	1,16				8	
		3		9,10	1,16				8	
Short Circuit Current	I _{OS}	7			6				8	

- NOTES:** 1. Test outputs of the device must be tested by sequencing through the truth table. All input, power supply and ground voltages must be maintained between tests. The clock input is the waveform shown.
 2. In addition to meeting the output levels specified, the device must divide by 5 or 8 during this test. The clock input is the waveform shown.
 3. In addition to meeting the output levels specified, the device must divide by 6 or 9 during this test. The clock input is the waveform shown.



MC12009 MC12011

SWITCHING CHARACTERISTICS

Characteristic	Symbol	Pin Under Test	MC12009, MC12011									TEST VOLTAGES/WAVEFORMS APPLIED TO PINS LISTED BELOW:								
			-30°C			25°C			85°C			Unit	Pulse Gen.1	Pulse Gen.2	Pulse Gen.3	V_{IHmin} ↑	V_{ILmin} ↑	V_F -3.0 V	V_{EE} -3.0 V	V_{CC} +2.0
			Min	Typ	Max	Min	Typ	Max	Min	Typ	Max									
Propagation Delay (See Figures 3 and 5)	t_{15+2+} t_{15+2-} t_{5+7+} t_{5-7-}	2 2 7 7	— — — —	— — — —	8.1 7.5 8.4 6.5	— — — —	— — — —	8.1 7.5 8.1 6.5	— — — —	— — — —	8.9 8.2 8.9 7.1	ns ↓ A A	15 15 — —	— — — —	— — — —	— — — —	11,12,13 11,12,13 — —	9,10 9,10 — —	8 8 8 8	1.6,16 1.6,16 1.6,16 1.6,16
Setup Time (See Figures 4 and 5)	t_{setup1} t_{setup2}	11 9	5.0 5.0	— —	— —	5.0 5.0	— —	— —	5.0 5.0	— —	— —	ns ns	15 15	* —	— *	— —	— 11,12,13	9,10 *	8 8	1.6,16 1.6,16
Release Time (See Figures 4 and 5)	t_{rel1} t_{rel2}	11 9	5.0 5.0	— —	— —	5.0 5.0	— —	— —	5.0 5.0	— —	— —	ns ns	15 15	* —	— *	— —	— 11,12,13	9,10 *	8 8	1.6,16 1.6,16
Toggle Frequency (See Figure 6) MC12009 : 5/6 MC12011 : 8/9	f_{max}	2	— 440 500	— — —	— — —	— 480 550	— — —	— — —	— 440 500	— — —	— — —	MHz	— — —	— — —	— — —	11 11	— — —	— — —	8 8 8	16 16 16

*Test inputs sequentially, with Pulse Generator 2 or 3 as indicated connected to input under test, and the voltage indicated applied to the other input(s) of the same type (i.e., MECL or M TTL).

	-30°C	25°C	85°C	
$\uparrow V_{IHmin}$	1.03	1.115	1.20	Vdc
$\uparrow V_{ILmin}$	0.175	0.200	0.235	Vdc

Figure 3. AC Voltage Waveforms

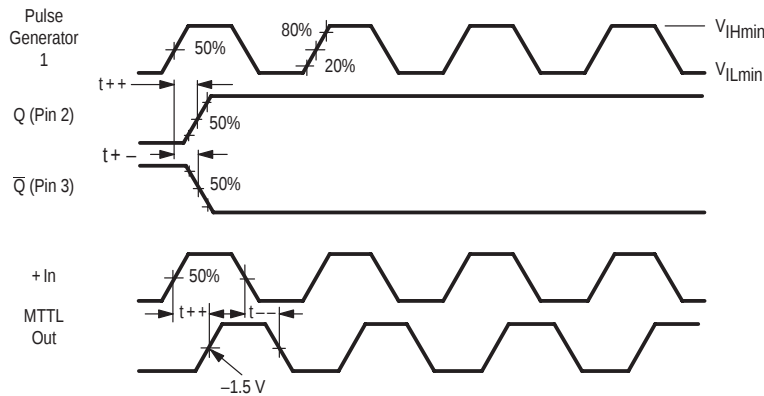


Figure 4. Setup and Release Time Waveforms

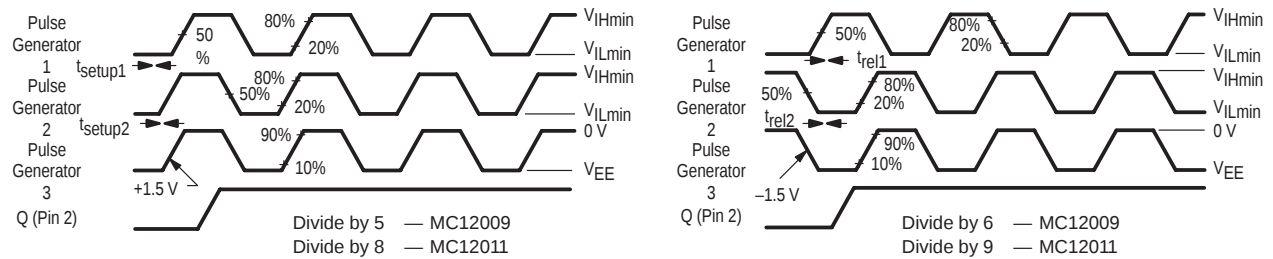
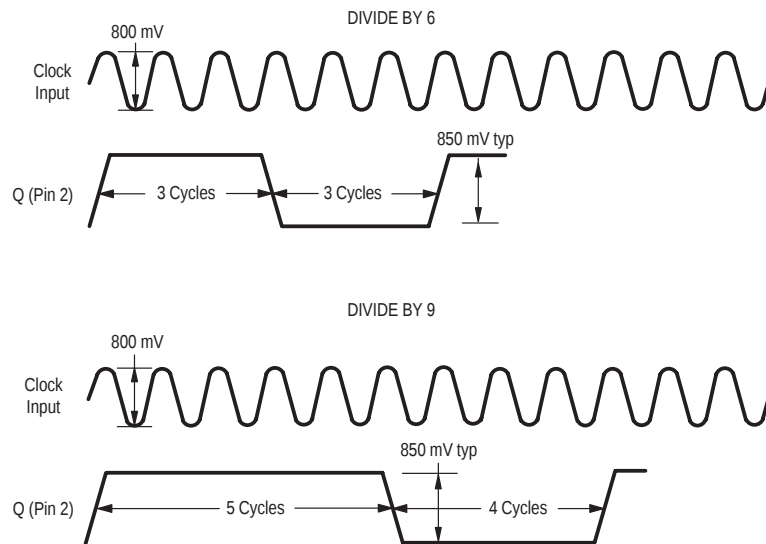
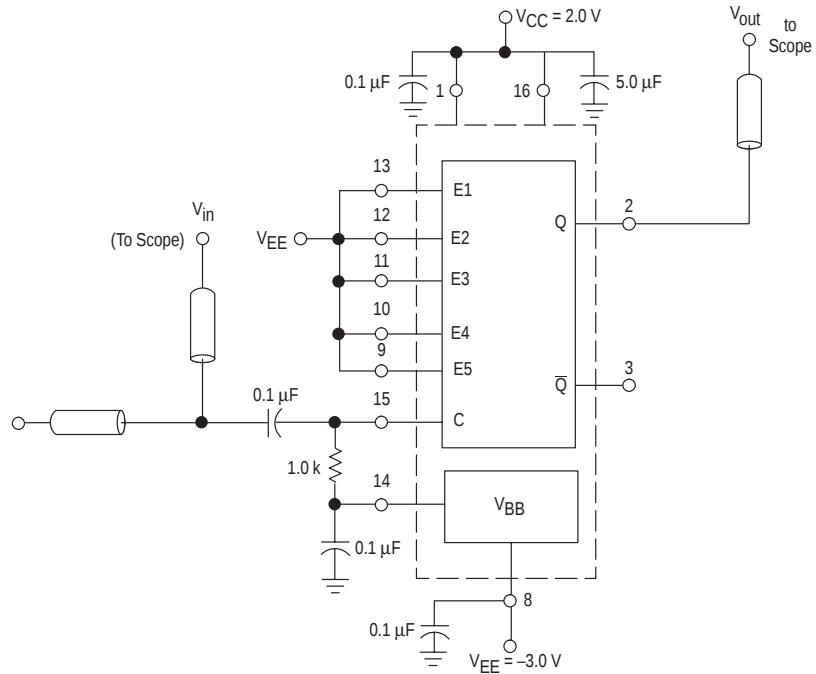


Figure 5. AC Test Circuit

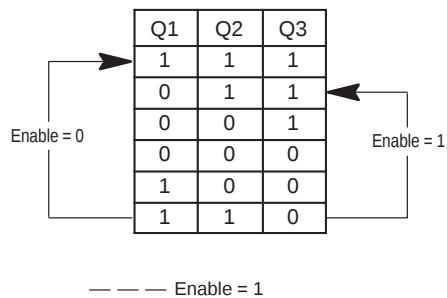


Figure 6. Maximum Frequency Test Circuit

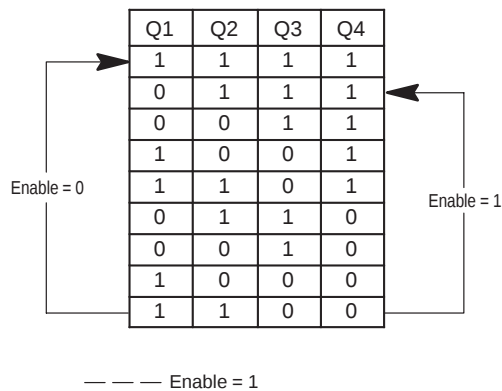
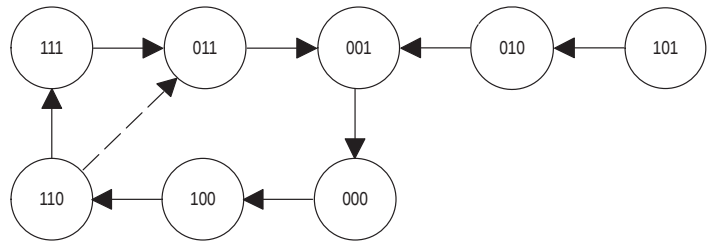


MC12009 MC12011

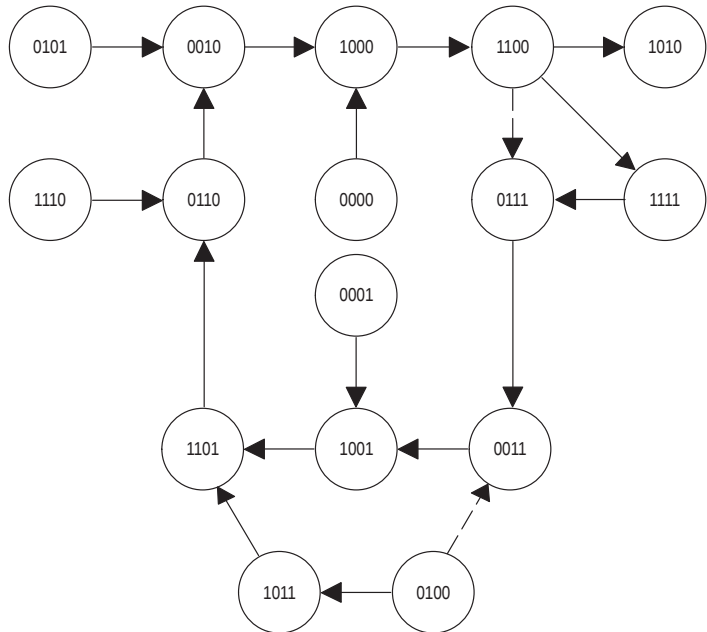
Figure 7. State Diagram



DIVIDE BY 5/6 (MC12009/MC12509)



DIVIDE BY 8/9 (MC12011)



APPLICATIONS INFORMATION

The primary application of these devices is as a high-speed variable modulus prescaler in the divide by N section of a phase-locked loop synthesizer used as the local oscillator of two-way radios.

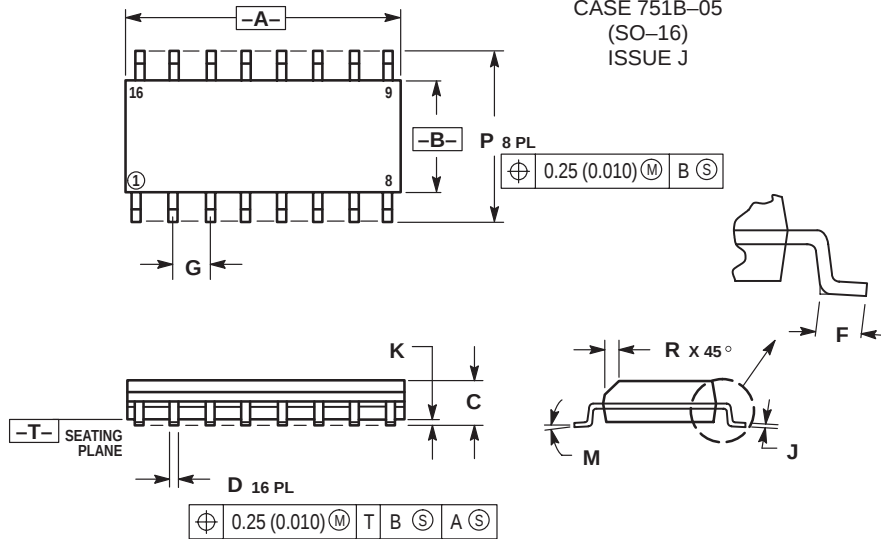
Proper VHF termination techniques should be followed when the clock is separated from the prescaler by any appreciable distance.

In their basic form, these devices will divide by 5/6 or 8/9. Division by 5, or 8 occurs when any one or all of the five gate inputs E1 through E5 are high. Division by 6, or 9 occurs when all inputs E1 through E5 are low. (Unconnected MTTL inputs are normally high, unconnected MECL inputs are normally low). With the addition of extra parts, many different division configurations may be obtained.

MC12009 MC12011

OUTLINE DIMENSIONS

D SUFFIX PLASTIC PACKAGE CASE 751B-05 (SO-16) ISSUE J

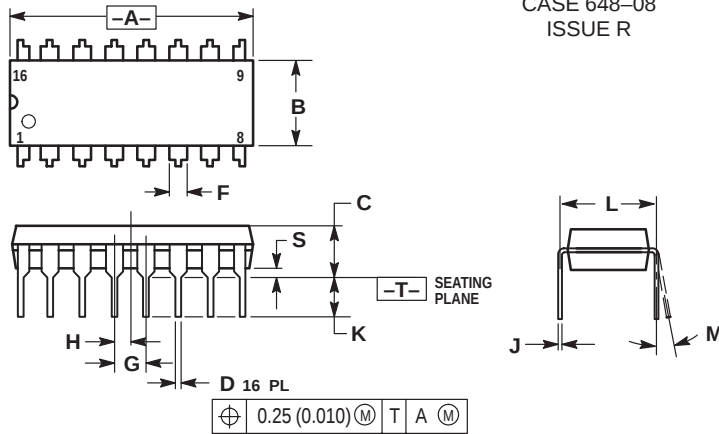


NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DIMENSIONS A AND B DO NOT INCLUDE MOLD PROTRUSION.
4. MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.
5. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.

DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	9.80	10.00	0.386	0.393
B	3.80	4.00	0.150	0.157
C	1.35	1.75	0.054	0.068
D	0.35	0.49	0.014	0.019
F	0.40	1.25	0.016	0.049
G	1.27 BSC		0.050 BSC	
J	0.19	0.25	0.008	0.009
K	0.10	0.25	0.004	0.009
M	0°	7°	0°	7°
P	5.80	6.20	0.229	0.244
R	0.25	0.50	0.010	0.019

P SUFFIX PLASTIC PACKAGE CASE 648-08 ISSUE R



NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.
3. DIMENSION L TO CENTER OF LEADS WHEN FORMED PARALLEL.
4. DIMENSION B DOES NOT INCLUDE MOLD FLASH.
5. ROUNDED CORNERS OPTIONAL.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.740	0.770	18.80	19.55
B	0.250	0.270	6.35	6.85
C	0.145	0.175	3.69	4.44
D	0.015	0.021	0.39	0.53
F	0.040	0.70	1.02	1.77
G	0.100 BSC		2.54 BSC	
H	0.050 BSC		1.27 BSC	
J	0.008	0.015	0.21	0.38
K	0.110	0.130	2.80	3.30
L	0.295	0.305	7.50	7.74
M	0°	10°	0°	10°
S	0.020	0.040	0.51	1.01

MC12009 MC12011
NOTES

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NOTES

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